

TOSHIBA CMOS DIGITAL INTEGRATED CIRCUIT SILICON MONOLITHIC

TC74VHCT04F, TC74VHCT04FN, TC74VHCT04FS

HEX INVERTER

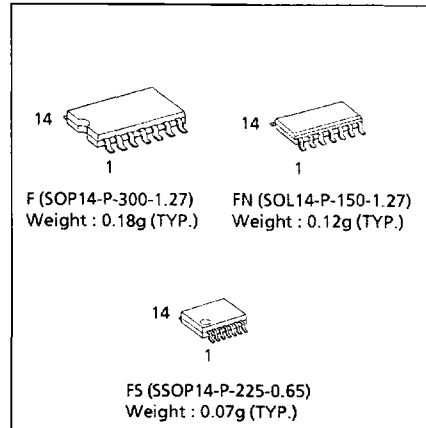
The TC74VHCT04 is an advanced high speed CMOS INVERTER fabricated with silicon gate C²MOS technology. It achieves the high speed operation similar to equivalent Bipolar Schottky TTL while maintaining the CMOS low power dissipation.

The input voltage are compatible with TTL output voltage. This device may be used as a level converter for interfacing 3.3V to 5V system.

Input protection and output circuit ensure that 0 to 7V can be applied to the input and output pins without regard to the supply voltage. These structure prevents device destruction due to mismatched supply and input/output voltages such as battery back up, hot board insertion, etc.

FEATURES:

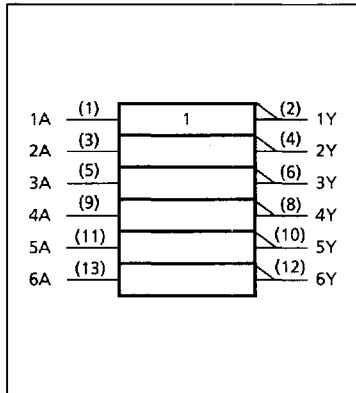
- High Speed..... $t_{pd} = 4.7ns$ (typ.) at $V_{CC} = 5V$
- Low Power Dissipation..... $I_{CC} = 2\mu A$ (Max.) at $T_a = 25^\circ C$
- Compatible with TTL outputs.... $V_{IL} = 0.8V$ (Max.)
 $V_{IH} = 2.0V$ (Min.)
- Power Down Protection is provided on all inputs and outputs.
- Balanced Propagation Delays..... $t_{pLH} \approx t_{pHL}$
- Low Noise $V_{OLP} = 1.0V$ (Max.)
- Pin and Function Compatible with 74ALS04



APPLICATION NOTE

This device can drive the components with CMOS input level by adding a external pull up resistor to output terminal.

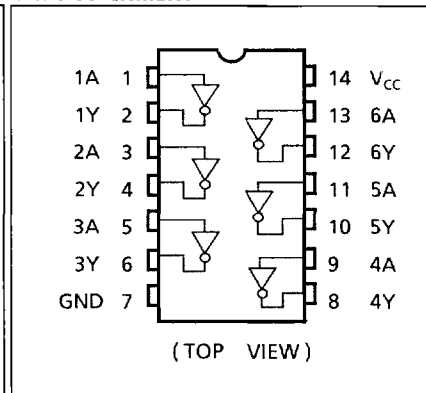
IEC LOGIC SYMBOL



TRUTH TABLE

A	Y
L	H
H	L

PIN ASSIGNMENT



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ABSOLUTE MAXIMUM RATINGS

PARAMETER	SYMBOL	VALUE	UNIT
Supply Voltage Range	V_{CC}	-0.5~7.0	V
DC Input Voltage	V_{IN}	-0.5~7.0	V
DC Output Voltage	V_{OUT}	-0.5~7.0	V
Input Diode Current	I_{IK}	-20	mA
Output Diode Current	I_{OK}	-20	mA
DC Output Current	I_{OUT}	±25	mA
DC V_{CC} /Ground Current	I_{CC}	±50	mA
Power Dissipation	P_D	180	mW
Storage Temperature	T_{stg}	-65~150	°C

RECOMMENDED OPERATING CONDITIONS

PARAMETER	SYMBOL	VALUE	UNIT
Supply Voltage	V_{CC}	4.5~5.5	V
Input Voltage	V_{IN}	0~5.5	V
Output Voltage	V_{OUT}	0~5.5	V
Operating Temperature	T_{opr}	-40~85	°C
Input Rise and Fall Time	dt/dv	0~20	ns/V

DC ELECTRICAL CHARACTERISTICS

PARAMETER	SYMBOL	CONDITON	V_{CC} (V)	$T_a = 25^\circ\text{C}$			$T_a = -40\sim 85^\circ\text{C}$		UNIT	
				MIN.	TYP.	MAX.	MIN.	MAX.		
High - Level Input Voltage	V_{IH}		4.5~5.5	2.0	-	-	2.0	-	V	
Low - Level Input Voltage	V_{IL}		4.5~5.5	-	-	0.8	-	0.8	V	
High - Level Output Voltage	V_{OH}	$V_{IN} = V_{IL}$	$I_{OH} = -50\mu\text{A}$	4.5	3.15	3.65	-	3.15	-	V
			$I_{OH} = -8\text{mA}$	4.5	2.50	-	-	2.40	-	
Low - Level Output Voltage	V_{OL}	$V_{IN} = V_{IH}$	$I_{OL} = 50\mu\text{A}$	4.5	-	0.0	0.10	-	0.10	V
			$I_{OL} = 8\text{mA}$	4.5	-	-	0.36	-	0.44	
Input Leakage Current	I_{IN}	$V_{IN} = 5.5\text{V or GND}$	0~5.5	-	-	±0.1	-	±1.0	μA	
Quiescent Supply Current	I_{CC}	$V_{IN} = V_{CC or GND}$	5.5	-	-	2.0	-	20.0		
		I_{CCT}	PER INPUT : $V_{IN} = 3.4\text{V}$ OTHER INPUT : $V_{CC or GND}$	5.5	-	-	1.35	-	1.50	mA
Output Leakage Current	I_{OPD}	$V_{OUT} = 5.5\text{V}$	0	-	-	+0.5	-	+5.0	μA	

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AC ELECTRICAL CHARACTERISTICS (Input $t_r = t_f = 3ns$)

PARAMETER	SYMBOL	TEST CONDITION		Ta = 25°C			Ta = -40~85°C		UNIT
		V _{CC} (V)	CL (pF)	MIN.	TYP.	MAX.	MIN.	MAX.	
Propagation Delay Time	t _{pLH}	5.0 ± 0.5	15	—	4.7	6.7	1.0	7.5	ns
	t _{pHL}		50	—	5.5	7.7	1.0	8.5	
Input Capacitance	C _{IN}			—	4	10	—	10	pF
Power Dissipation Capacitance	C _{PD}	(Note 1)		—	11	—	—	—	

Note (1) C_{PD} is defined as the value of the internal equivalent capacitance which is calculated from the operating current consumption without load.

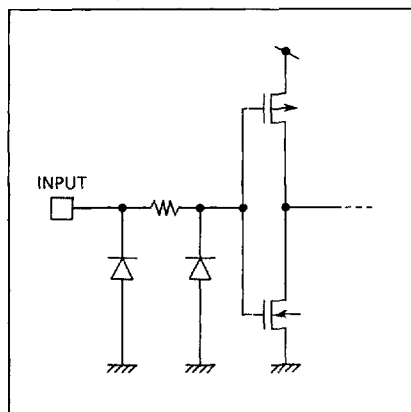
Average operating current can be obtained by the equation :

$$I_{CC(OPR)} = C_{PD} \cdot V_{CC} \cdot f_{IN} + I_{CC} / 6 \text{ (per Gate)}$$

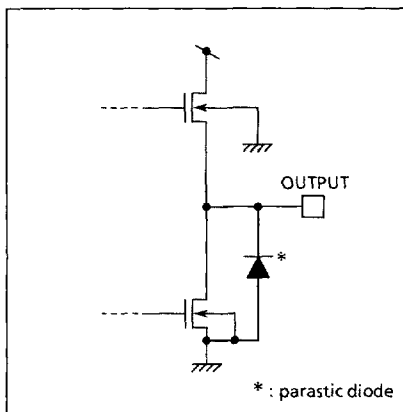
NOISE CHARACTERISTICS (Input $t_r = t_f = 3ns$)

PARAMETER	SYMBOL	TEST CONDITION	Ta = 25°C			UNIT
			V _{CC} (V)	TYP.	LIMIT	
Quiet Output Maximum Dynamic V _{OL}	V _{OLP}	C _L = 50pF	5.0	0.8	1.0	V
Quiet Output Minimum Dynamic V _{OL}	V _{OLV}	C _L = 50pF	5.0	-0.8	-1.0	V
Minimum High Level Dynamic Input Voltage	V _{IHD}	C _L = 50pF	5.0	—	2.0	V
Maximum Low Level Dynamic Input Voltage	V _{ILD}	C _L = 50pF	5.0	—	0.8	V

INPUT EQUIVALENT CIRCUIT



OUTPUT EQUIVALENT CIRCUIT



* : parastic diode